74HC253; 74HCT253 Dual 4-input multiplexer; 3-state Rev. 6 — 1 February 2016

Product data sheet

General description

The 74HC253; 74HCT253 is a dual 4-bit multiplexer, each with four binary inputs (nI0 to nl3), an output enable input (nOE) and shared select inputs (S0 and S1). One of the four binary inputs is selected by the select inputs and routed to the output nY. A HIGH on nOE causes the outputs to assume a high-impedance OFF-state. Inputs include clamp diodes. This enables the use of current limiting resistors to interface inputs to voltages in excess of V_{CC} .

Features and benefits 2.

- Non-inverting data path
- 3-state outputs interface directly with system bus
- Complies with JEDEC standard no. 7A
- Common select inputs
- Separate output enable inputs
- Input levels:
 - ◆ For 74HC253: CMOS level
 - For 74HCT253: TTL level
- ESD protection:
 - HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V
- Multiple package options
- Specified from –40 °C to +85 °C and from –40 °C to +125 °C

Applications

- Data selectors
- Data multiplexers

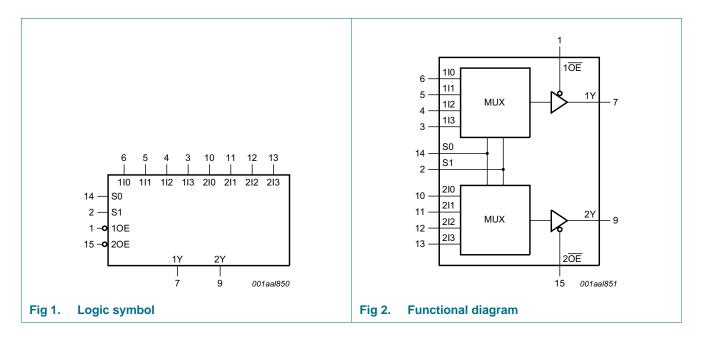


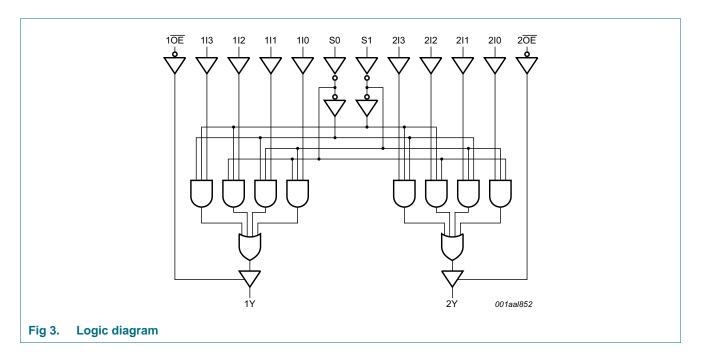
4. Ordering information

Table 1. Ordering information

Type number	Package					
	Temperature range Name Description					
74HC253D	−40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width	SOT109-1		
74HCT253D			3.9 mm			
74HC253DB	−40 °C to +125 °C	SSOP16	plastic shrink small outline package; 16 leads;	SOT338-1		
74HCT253DB			body width 5.3 mm			

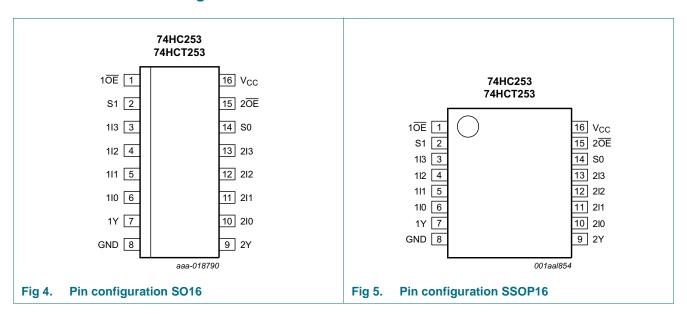
5. Functional diagram





6. Pinning information

6.1 Pinning



6.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
1 OE , 2 OE	1, 15	output enable inputs (active LOW)
S0, S1	14, 2	data select inputs
110, 111, 112, 113	6, 5, 4, 3	data inputs source 1
1Y	7	multiplexer output source 1
GND	8	ground (0 V)
2Y	9	multiplexer output source 2
210, 211, 212, 213	10, 11, 12, 13	data inputs source 2
V _{CC}	16	supply voltage

Functional description 7.

Function table[1] Table 3.

select Inputs		data inpi	uts	output enable	output		
S0	S1	nI0	nl1	nl2	nl3	nOE	nY
Χ	X	X	Х	Х	Х	Н	Z
L	L	L	Х	Х	Х	L	L
L	L	Н	Х	Х	X	L	Н
Н	L	X	L	Х	Х	L	L
Н	L	X	Н	Х	Х	L	Н
L	Н	X	Х	L	Х	L	L
L	Н	X	Х	Н	X	L	Н
Н	Н	X	Х	Х	L	L	L
Н	Н	Х	Х	Х	Н	L	Н

^[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

Limiting values

Table 4. **Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{CC}	supply voltage			-0.5	+7.0	V
I _{IK}	input clamping current	$V_{I} < -0.5 \text{ V or } V_{I} > V_{CC} + 0.5 \text{ V}$	<u>[1]</u>	-	±20	mA
I _{OK}	output clamping current	$V_{O} < -0.5 \text{ V or } V_{O} > V_{CC} + 0.5 \text{ V}$	[1]	-	±50	mA
Io	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$		-	±35	mA
I _{CC}	supply current			-	70	mA
I _{GND}	ground current			-70	-	mA
T _{stg}	storage temperature			-65	+150	°C

Table 4. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
P _{tot}	total power dissipation	$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}$				
		SO16 package	[2]	-	500	mW
		SSOP16 package	[3]	-	500	mW

- [1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
- [2] P_{tot} derates linearly with 8 mW/K above 70 °C.
- [3] P_{tot} derates linearly with 5.5 mW/K above 60 °C.

9. Recommended operating conditions

Table 5. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions	74HC253			74HCT253			Unit	
			Min	Тур	Max	Min	Тур	Max		
V_{CC}	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V	
VI	input voltage		0	-	V _{CC}	0	-	V _{CC}	V	
Vo	output voltage		0	-	V _{CC}	0	-	V _{CC}	V	
T _{amb}	ambient temperature		-40	-	+125	-40	-	+125	°C	
Δt/ΔV	input transition rise and fall rate	V _{CC} = 2.0 V	-	-	625	-	-	-	ns/V	
		V _{CC} = 4.5 V	-	1.67	139	-	1.67	139	ns/V	
		V _{CC} = 6.0 V	-	-	83	-	-	-	ns/V	

10. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	25 °C		-40 °C t	o +85 °C	-40 °C to +125 °C		Unit	
			Min	Тур	Max	Min	Max	Min	Max	
74HC25	3									
V _{IH}	HIGH-level	V _{CC} = 2.0 V	1.5	1.2	-	1.5	-	1.5	-	V
	input voltage	V _{CC} = 4.5 V	3.15	2.4	-	3.15	-	3.15	-	V
		V _{CC} = 6.0 V	4.2	3.2	-	4.2	-	4.2	-	V
V _{IL}	LOW-level	V _{CC} = 2.0 V	-	0.8	0.5	-	0.5	-	0.5	V
	input voltage	V _{CC} = 4.5 V	-	2.1	1.35	-	1.35	-	1.35	V
		$V_{CC} = 6.0 \text{ V}$	-	2.8	1.8	-	1.8	-	1.8	V
V _{OH}	HIGH-level	$V_I = V_{IH}$ or V_{IL}								
	output voltage	$I_O = -20 \mu A$; $V_{CC} = 2.0 \text{ V}$	1.9	2.0	-	1.9	-	1.9	-	V
		$I_O = -20 \mu A$; $V_{CC} = 4.5 \text{ V}$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_O = -20 \mu A$; $V_{CC} = 6.0 \text{ V}$	5.9	6.0	-	5.9	-	5.9	-	V
		$I_{O} = -6.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.98	4.32	-	3.84	-	3.7	-	V
		$I_{O} = -7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.48	5.81	-	5.34	-	5.2	-	V

Table 6. Static characteristics ... continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		–40 °C t	o +85 °C	-40 °C to	o +125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
V _{OL}	LOW-level	$V_I = V_{IH}$ or V_{IL}								
	output voltage	$I_O = 20 \mu A; V_{CC} = 2.0 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \mu A; V_{CC} = 4.5 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \mu A; V_{CC} = 6.0 \text{ V}$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 6.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	0.15	0.26	-	0.33	-	0.4	V
		$I_O = 7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	0.16	0.26	-	0.33	-	0.4	V
l _l	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±0.1	-	±1.0	-	±1.0	μА
l _{OZ}	OFF-state output current	$V_I = V_{IH} \text{ or } V_{IL};$ $V_O = V_{CC} \text{ or GND};$ $V_{CC} = 6.0 \text{ V}$	-	-	±0.5	-	±5.0	-	±10.0	μА
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0 \text{ V}$	-	-	8.0	-	80	-	160	μΑ
Cı	input capacitance		-	3.5	-	-	-	-	-	pF
74HCT2	53									-
V _{IH}	HIGH-level input voltage			1.6	-	2.0	-	2.0	-	V
V_{IL}	LOW-level input voltage	V _{CC} = 4.5 V to 5.5 V	-	1.2	0.8	-	0.8	-	0.8	V
V _{OH}	HIGH-level	$V_I = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 \text{ V}$								
	output voltage	I _O = -20 μA	4.4	4.5	-	4.4	-	4.4	-	V
		$I_O = -6 \text{ mA}$	3.98	4.32	-	3.84	-	3.7	-	V
V _{OL}	LOW-level	$V_I = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 \text{ V}$								
	output voltage	I _O = 20 μA	-	0	0.1	-	0.1	-	0.1	V
		$I_{O} = 6.0 \text{ mA}$	-	0.15	0.26	-	0.33	-	0.4	V
l _l	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±0.1	-	±1.0	-	±1.0	μΑ
l _{OZ}	OFF-state output current	$V_I = V_{IH}$ or V_{IL} ; $V_O = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±0.5	-	±5.0	-	±10	μА
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	-	8.0	-	80	-	160	μА
Δl _{CC}	additional supply current	$\begin{aligned} &V_I = V_{CC} - 2.1 \text{ V;} \\ &\text{other inputs at } V_{CC} \text{ or GND;} \\ &V_{CC} = 4.5 \text{ V to } 5.5 \text{ V;} \\ &I_O = 0 \text{ A} \end{aligned}$								
		per input pin; 1In, 2In inputs	-	40	144	-	180	-	196	μΑ
		per input pin; nOE input	-	110	396	-	495	-	539	μΑ
		per input pin; Sn input	-	110	396	-	495	-	539	μΑ
Cı	input capacitance		-	3.5	-	-	-	-	-	pF

11. Dynamic characteristics

Table 7. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); For test circuit see Figure 8.

Symbol	Parameter	Conditions	25	°C	-40 °C to +85 °C	-40 °C to +125 °C	Unit
			Тур	Max	Max	Max	
74HC25	3						-1
t _{pd}	propagation delay	1In to 1Y or 2In to 2Y; see Figure 6					
		V _{CC} = 2.0 V	55	175	220	265	ns
		V _{CC} = 4.5 V	20	35	44	53	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	17	-	-	-	ns
		V _{CC} = 6.0 V	16	30	37	45	ns
		Sn to nY; see Figure 6					
		V _{CC} = 2.0 V	58	175	220	265	ns
		V _{CC} = 4.5 V	21	35	44	53	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	18	-	-	-	ns
		V _{CC} = 6.0 V	17	30	37	45	ns
t _{en}	enable time	nOE to nY; see Figure 7					
		V _{CC} = 2.0 V	30	100	125	150	ns
	V _{CC} = 4.5 V	11	20	25	30	ns	
		V _{CC} = 6.0 V	9	17	21	26	ns
t _{dis}	disable time	nOE to nY; see Figure 7					
		V _{CC} = 2.0 V	41	150	190	225	ns
		V _{CC} = 4.5 V	15	30	38	45	ns
		V _{CC} = 6.0 V	12	26	33	38	ns
t _t	transition time	see Figure 6					
		V _{CC} = 2.0 V	14	60	75	90	ns
		V _{CC} = 4.5 V	5	12	15	18	ns
		V _{CC} = 6.0 V	4	10	13	15	ns
C _{PD}	power dissipation capacitance	per multiplexer; [5] V _I = GND to V _{CC}	55	-	-	-	pF
74HCT2	53						_
t _{pd}	propagation delay	1In to 1Y or 2In to 2Y; see Figure 6	,				
		V _{CC} = 4.5 V	20	38	48	57	ns
		V _{CC} = 5.0 V; C _L = 15 pF	17	-	-	-	ns
		Sn to nY; see Figure 6					
		V _{CC} = 4.5 V	22	40	50	60	ns
		V _{CC} = 5.0 V; C _L = 15 pF	19	-			ns
t _{en}	enable time	$\overline{\text{NOE}}$ to nY; $V_{\text{CC}} = 4.5 \text{ V}$; see Figure 7	14	30	38	45	ns

Table 7. **Dynamic characteristics** ...continued

Voltages are referenced to GND (ground = 0 V); For test circuit see Figure 8.

Symbol	Parameter	Conditions	25	°C	-40 °C to +85 °C	-40 °C to +125 °C	Unit
			Тур	Max	Max	Max	
t _{dis}	disable time	$\overline{\text{NOE}}$ to nY; $V_{\text{CC}} = 4.5 \text{ V}$; see Figure 7	13	30	38	45	ns
t _t	transition time	V _{CC} = 4.5 V; see Figure 6	5	12	15	18	ns
C_{PD}	power dissipation capacitance	per multiplexer; [5] V _I = GND to V _{CC} – 1.5 V	55	-	-	-	pF

- [1] t_{pd} is the same as t_{PHL} , t_{PLH} .
- ten is the same as tPZH, tPZL.
- [3] t_{dis} is the same as t_{PHZ} , t_{PLZ} .
- [4] t_t is the same as t_{THL} , t_{TLH} .
- [5] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

 $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o)$ where:

 f_i = input frequency in MHz;

fo = output frequency in MHz;

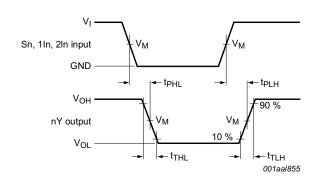
C_L = output load capacitance in pF;

V_{CC} = supply voltage in V;

N = number of inputs switching;

 $\sum (C_L \times V_{CC}^2 \times f_o) = \text{sum of outputs.}$

12. Waveforms



Measurement points are given in Table 8.

V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Propagation delays input (Sn, 1ln, 2ln) to output (nY) and output (nY) transition times Fig 6.

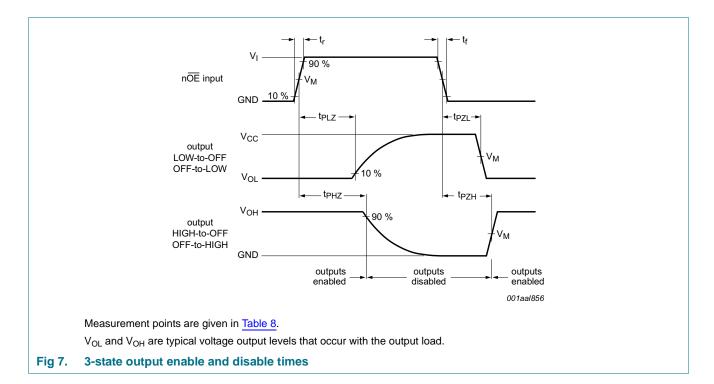
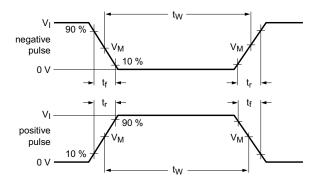
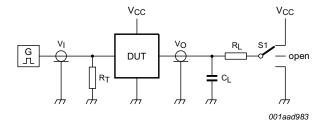


Table 8. Measurement points

Туре	Input	Output
	V _M	V _M
74HC253	0.5V _{CC}	0.5V _{CC}
74HCT253	1.3 V	1.3 V





Measurement points are given in Table 8 and test data is given in Table 9.

Definitions test circuit:

 R_T = Termination resistance should be equal to output impedance Z_o of the pulse generator.

 C_L = Load capacitance including jig and probe capacitance.

R_L = Load resistor.

Fig 8. Test circuit for measuring switching times

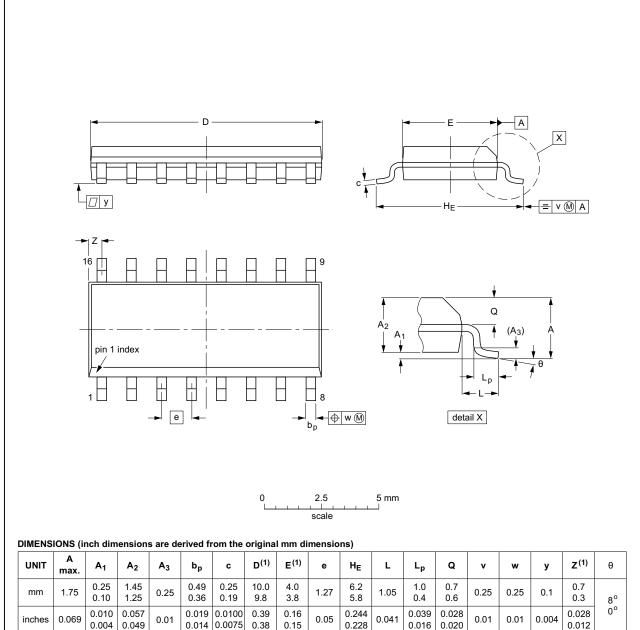
Table 9. Test data

Туре	Input		Load		Switch position			
	V _I	t _r , t _f	C _L	R_L	t _{PHL} , t _{PLH}	t _{PZH} , t _{PHZ}	t _{PZL} , t _{PLZ}	
74HC253	V _{CC}	6 ns	50 pF	1 kΩ	open	GND	V _{CC}	
74HCT253	3 V	6 ns	50 pF	1 kΩ	open	GND	V _{CC}	

13. Package outline

SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1



inches

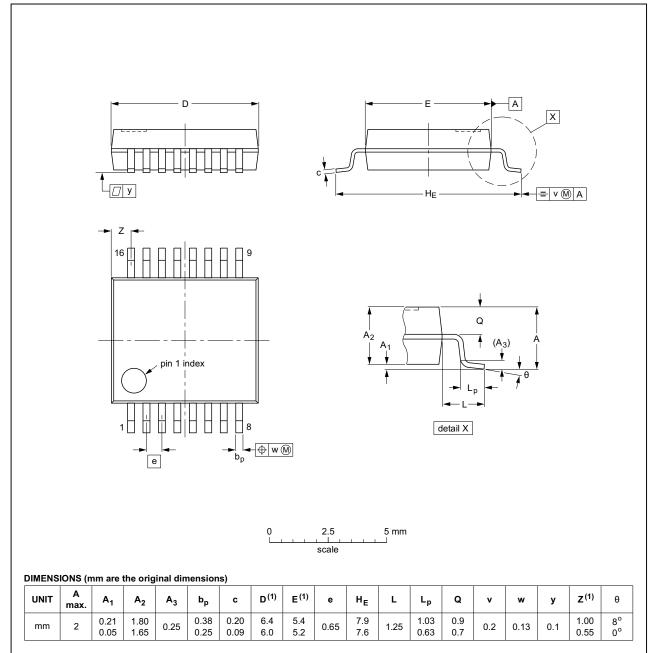
1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE	REFERENCES				EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT109-1	076E07	MS-012				99-12-27 03-02-19

Fig 9. Package outline SOT109-1 (SO16)

SSOP16: plastic shrink small outline package; 16 leads; body width 5.3 mm

SOT338-1



Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE	REFERENCES				EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA		PROJECTION	CTION ISSUE DATE
SOT338-1		MO-150				99-12-27 03-02-19

Fig 10. Package outline SOT338-1 (SSOP16)

14. Abbreviations

Table 10. Abbreviations

Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

15. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
74HC_HCT253 v.6	20160201	Product data sheet	-	74HC_HCT253 v.5	
Modifications:	Type numbers 74	HC253N and 74HCT253	N (SOT38-4) removed		
74HC_HCT253 v.5	20150121	Product data sheet	-	74HC_HCT253 v.4	
Modifications:	• Table 7: Power dissipation capacitance condition for 74HCT253 is corrected.				
74HC_HCT253 v.4	20111212	Product data sheet	-	74HC_HCT253 v.3	
Modifications:	Legal pages upda	ated.			
74HC_HCT253 v.3	20100422	Product data sheet	-	74HC_HCT253_CNV v.2	
74HC_HCT253_CNV v.2	970828	Product specification	-	-	

16. Legal information

16.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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74HC HCT253

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74HC253; 74HCT253

Dual 4-input multiplexer; 3-state

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